## Notice of References Cited Application/Control No. 10/564,187 Examiner Sarah Su Applicant(s)/Patent Under Reexamination ITO ET AL. Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,356,951 B1	03-2002	Gentry, Jr., Denton E.	709/250
*	В	US-2004/0170121 A1	09-2004	Kim et al.	370/208
*	O	US-2004/0252725 A1	12-2004	Sun et al.	370/503
*	D	US-2008/0170691 A1	07-2008	Chang et al.	380/270
*	Е	US-2008/0273700 A1	11-2008	Wentink, Maarten Menzo	380/270
*	H	US-2010/0017686 A1	01-2010	Luby et al.	714/776
*	G	US-2010/0031036 A1	02-2010	CHAUNCEY et al.	713/168
*	Ι	US-2010/0150054 A1	06-2010	Becker et al.	370/316
*	_	US-7,765,402 B2	07-2010	Clark et al.	713/168
	٦	US-			
	K	US-			
	┙	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Ν					
	0					
	Р					
	Ø					
	R					
	S					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	w	
	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.